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| Notice of References Cited | | Application/Control No. 10/628,885 | Applicant(s)/Patent Under Reexamination ENNS ET AL. | |
| | | Examiner CHELCIE DAYE | Art Unit 2161 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|--|-----------------|----------------|----------------|
| * | A US-2004/0260818 | 12-2004 | Valois et al. | 709/229 |
| * | B US-6,973,460 | 12-2005 | Mitra, Kanchan | 707/103R |
| * | C US-2002/0156879 | 10-2002 | Delany et al. | 709/223 |
| * | D US-6,243,713 | 06-2001 | Nelson et al. | 707/104.1 |
| E | US- | | | |
| F | US- | | | |
| G | US- | | | |
| H | US- | | | |
| I | US- | | | |
| J | US- | | | |
| K | US- | | | |
| L | US- | | | |
| M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|--|-----------------|---------|------|----------------|
| N | | | | | |
| O | | | | | |
| P | | | | | |
| Q | | | | | |
| R | | | | | |
| S | | | | | |
| T | | | | | |

NON-PATENT DOCUMENTS

| * | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|
| U | |
| V | |
| W | |
| X | |

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